Microstructural Characterization of Materials

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Eun Soo Park

Office: 33-316

Telephone: 880-7221

Email: espark@snu.ac.kr

Office hours: by an appointment 1

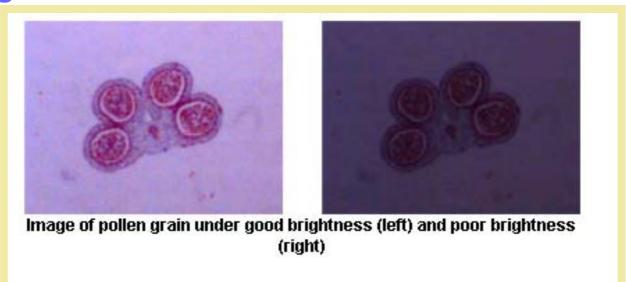
Contents for previous class

Image Quality

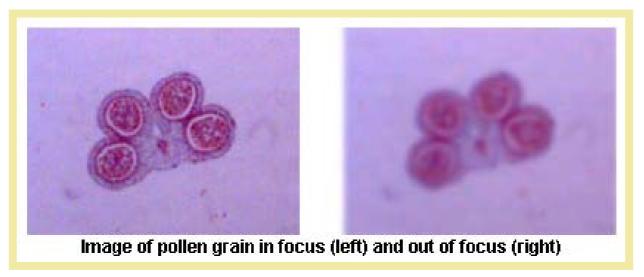
When you look at a specimen using a microscope, the quality of the image you see is assessed by the following:

- ·Brightness How light or dark is the image?
- •Focus Is the image blurry or well-defined?
- •Resolution How close can two points in the image be before they are no longer seen as two separate points?
- •Contrast What is the difference in lighting between adjacent areas of the specimen?

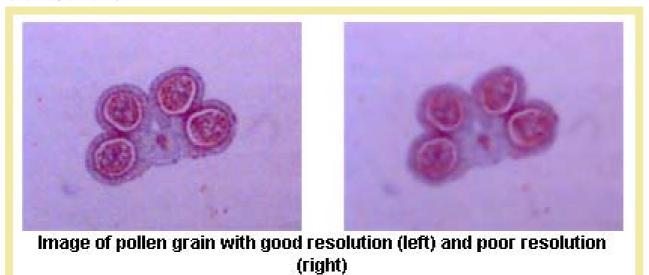
Brightness



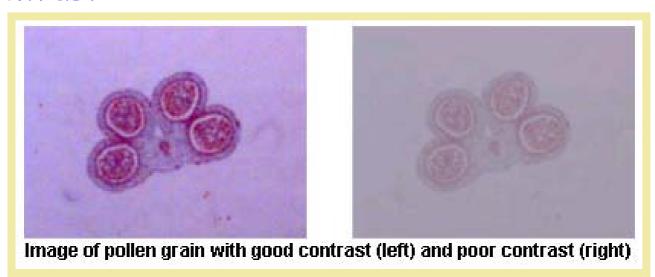
Focus



Resolution



Contrast



Chromatic Aberrations

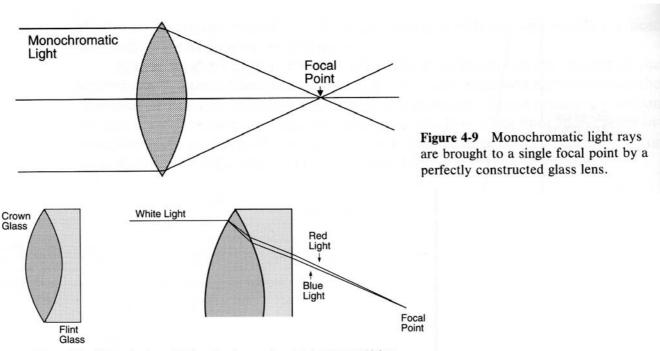


Figure 4-10 Chromatic aberration in a glass lens can be minimized by combining a converging and diverging lens of the correct strengths so that the light rays are brought to a single focal point.

광학현미경의 색수차 보정

- 1. 단색광 장치(monochromator)를 사용하여 단색 혹은 좁은 파장 의 빛만 렌즈를 통하면 색수차가 보정된다.
- 2. 서로 다른 굴절률을 가지는 렌즈들 (converging and diverging lens)을 함께 사용하여 색수차 보정

Spherical Aberrations(구면수차)

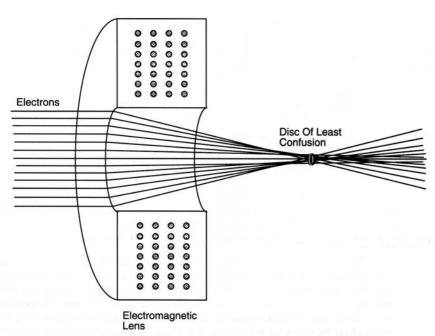


Figure 4-3 Electrons of equal energy passing through an electromagnetic lens are brought to different focal points. The closer the electrons are to the windings, the more the electrons are deflected by the magnetic field and the closer the focal point is to the lens.

구면수차는 연속적인 focal point 를 가지며 이들 focal point 중 가장 작은 electron beam diameter를 가지는 부분을 disc of least confusion(circle of minimum confusion)이라 한다

전자현미경의 해상도는 electron beam 이 가장 작은 diameter의 focal point를 가질 때 가장 크다.

Electrostatic Stigmator

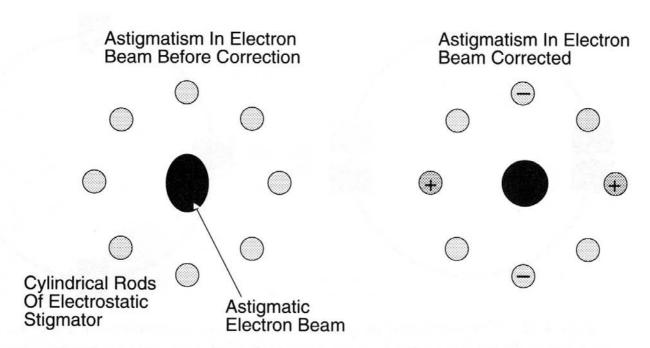


Figure 4-19 An electrostatic stigmator used to correct astigmatism of the electron beam by applying an electrostatic field to push and pull the electron beam into a circular cross section.

Stigmator: 전자빔의 비점수차(astigmatism)를 보정하는 장치-찌그러진 전자빔을 circular beam으로 만든다.

-정전기적(electrostatic), 자기적(magnetic) stigmator로 나누어짐

Correction of aberrations

All aberration corrections are designed to reduce in size of the disc of least confusion.

Corrections of chromatic aberration

- Combining lenses of different shapes and refractive indices
- Eliminating the variation in wavelength from the light source by using filters and special lamps.

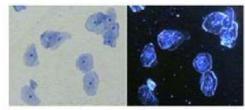
Corrections of astigmatism

It can be corrected relatively easy in electron microscope, because the magnetic lens strength can be adjusted in two perpendicular planes. Contrast is number of shades found in an image. A high contrast picture will have only two shades, black and white. The more shades you have, the less contrast, but more information.

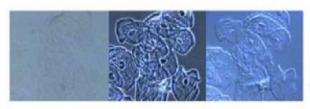
Color is also considered a form of contrast.



Absorption contrast



Diffraction contrast



Interference contrast

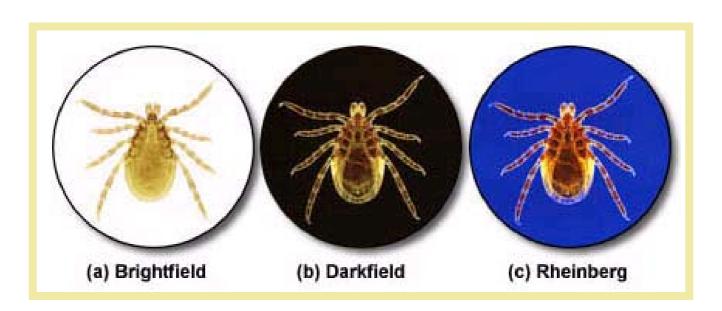
Contrast & Visibility

Absorption Reflection Interference Polarization Fluorescence

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Observation Modes

- •Brightfield This is the basic microscope configuration This technique has very little contrast.
- Darkfield This configuration enhances contrast.
- •Rheinberg illumination This set-up is similar to darkfield, but uses a series of filters to produce an "optical staining" of the specimen.



Imaging Modes

 Bright-field and dark-field are the most commonly used examination modes.

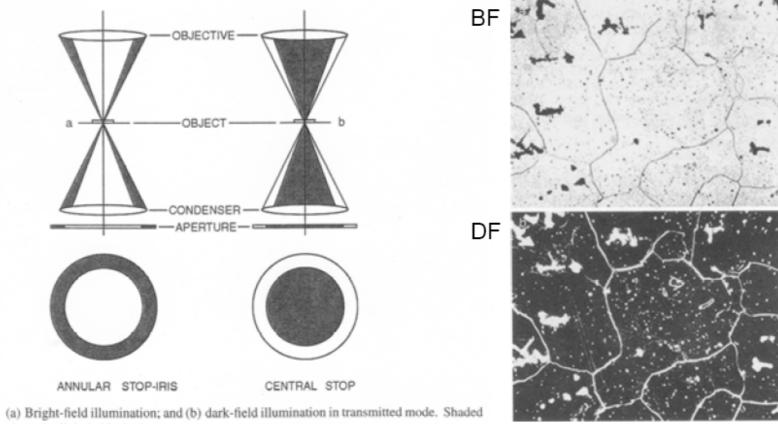


Figure 1.28 (a) Bright-field illumination; and (b) dark-field illumination in transmitted mode. Shaded areas indicate where the light is blocked.

- · Contrast 조절을 통한 더 많은 혹은 차별화된 정보 얻음
- Phase Contrast Microscopy
- Polarized Light Microscopy
- Fluorescence Microscopy
- Differential Interference Contrast (DIC)

- Recording The Image
- Film or Digital

· Presentation for various optical microscopes

- Phase contrast microscope
- Differential interference contrast microscope
- Fluorescence Microscopy
- Multi-photon laser scanning microscope
- 벡터장 나노 현미경
- Digital Holographic Microscope